

# GA100SICP12-227

# Silicon Carbide Junction Transistor/Schottky Diode Co-pack

 $V_{DS}$  = 1200 V  $R_{DS(ON)}$  = 12 m $\Omega$   $I_{D (Tc = 25^{\circ}C)}$  = 200 A  $h_{FE (Tc = 25^{\circ}C)}$  100

#### **Features**

- 175°C Maximum Operating Temperature
- · Gate Oxide free SiC switch
- Exceptional Safe Operating Area
- Integrated SiC Schottky Rectifier
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low output capacitance
- Positive temperature co-efficient of R<sub>DS,ON</sub>
- Suitable for connecting an anti-parallel diode

### **Advantages**

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal distortion
- High Amplifier Bandwidth
- Reduced cooling requirements
- Reduced system size

### **Package**

RoHS Compliant





SOT-227

### **Applications**

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

#### Maximum Ratings at T<sub>i</sub> = 175 °C, unless otherwise specified

Parameter Syr		Conditions	Values	Unit
SiC Junction Transistor				
Drain – Source Voltage	$V_{DS}$	V <sub>GS</sub> = 0 V	1200	V
Continuous Drain Current	I <sub>D</sub>	T <sub>C,MAX</sub> = 95 °C	100	Α
Gate Peak Current	I <sub>GM</sub>		10	Α
Turn-Off Safe Operating Area	RBSOA	$T_{VJ}$ = 175 °C, $I_{G}$ = 2 A, Clamped Inductive Load	$I_{D,max} = 100$ $\emptyset V_{DS} \le V_{DSmax}$	Α
Short Circuit Safe Operating Area	SCSOA	$T_{VJ}$ = 175 °C, $I_{G}$ = 1 A, $V_{DS}$ = 800 V, Non Repetitive	20	μs
Reverse Gate – Source Voltage	$V_{SG}$		30	V
Reverse Drain – Source Voltage	$V_{SD}$		25	V
Power Dissipation	$P_{tot}$	T <sub>C</sub> = 95 °C	133	W
Storage Temperature	$T_{stg}$		-55 to 175	°C
Free-wheeling Silicon Carbide diode				
DC-Forward Current	I <sub>F</sub>	T <sub>C</sub> ≤ 150 °C	100	Α
Non Repetitive Peak Forward Current	I <sub>FM</sub>	$T_C = 25 {}^{\circ}\text{C},  t_P = 10 \mu\text{s}$	3250	Α
Surge Non Repetitive Forward Current	$I_{F,SM}$	$t_P$ = 10 ms, half sine, $T_C$ = 25 °C	700	Α
Thermal Characteristics				
Thermal resistance, junction - case	$R_{thJC}$	SiC Junction Transistor	0.60	°C/W
Thermal resistance, junction - case	$R_{thJC}$	SiC Diode	0.60	°C/W

Machanical Dranautica		Values			
Mechanical Properties	min.	typ.	max.		
Mounting Torque	$M_d$		1.5		Nm
Terminal Connection Torque		1.3		1.5	Nm
Weight			29		g
Case Color		Black			
Dimensions		38 x 25.4 x 12 mm			

# GA100SICP12-227



Electrical Characteristics at T<sub>i</sub> = 175 °C, unless otherwise specified

Dovometer	Cumhal	Conditions	Values			Unit
Parameter	Symbol	Conditions -	min.	min. typ. max.		
SJT On-State Characteristics						
		I <sub>D</sub> = 100 A, I <sub>G</sub> = 1000 mA, T <sub>i</sub> = 25 °C		12		
Drain – Source On Resistance	R <sub>DS(ON)</sub>	I <sub>D</sub> = 100 A, I <sub>G</sub> = 2000 mA, T <sub>i</sub> = 125 °C		15		mΩ
	50(014)	$I_D = 100 \text{ A}, I_G = 4000 \text{ mA}, T_i = 175 °C$		22		
O-t- F		I <sub>G</sub> = 1000 mA, T <sub>j</sub> = 25 °C		3.3		
Gate Forward Voltage	$V_{GS(FWD)}$	I <sub>G</sub> = 1000 mA, T <sub>i</sub> = 175 °C		3.1		V
DC Current Gain	h	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 100 A, T <sub>i</sub> = 25 °C		100		
DC Current Gain	h <sub>FE</sub>	$V_{DS} = 5 \text{ V}, I_{D} = 100 \text{ A}, T_{j} = 175 ^{\circ}\text{C}$		TBD		
SJT Off-State Characteristics						
		$V_R$ = 1200 V, $V_{GS}$ = 0 V, $T_j$ = 25 °C		100		
Drain Leakage Current	$I_{DSS}$	$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125 ^{\circ}\text{C}$		150		μΑ
		$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 175 \text{ °C}$		200		
Gate Leakage Current	I <sub>SG</sub>	$V_{SG} = 20 \text{ V}, T_j = 25 ^{\circ}\text{C}$		20		nA
SJT Capacitance Characteristics				•		
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}, V_{D} = 1 \text{ V}, f = 1 \text{ MHz}$		tbd		pF
Reverse Transfer/Output Capacitance	$C_{rss}/C_{oss}$	$V_D = 1 V, f = 1 MHz$		tbd		pF
SJT Switching Characteristics						
Turn On Delay Time	$t_{d(on)}$			tbd		ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 800 V, I <sub>D</sub> = 100 A,		tbd		ns
Turn Off Delay Time	t <sub>d(off)</sub>	$R_{G(on)} = R_{G(off)} = tbd \Omega$ ,		tbd		ns
Fall Time	t <sub>f</sub>	FWD = GB100SLT12,		tbd		ns
Turn-On Energy Per Pulse	E <sub>on</sub>	T <sub>j</sub> = 25 °C Refer to Figure 15 for gate current		tbd		μJ
Turn-Off Energy Per Pulse	E <sub>off</sub>	waveform		tbd		μJ
Total Switching Energy	E <sub>ts</sub>			tbd		μJ
Turn On Delay Time	t <sub>d(on)</sub>			tbd		
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 800 V, I <sub>D</sub> = 100 A,		tbd		ns
Turn Off Delay Time	t <sub>d(off)</sub>	$R_{G(on)} = R_{G(off)} = tbd \Omega$ ,		tbd		ns
Fall Time	t <sub>f</sub>	FWD = GB100SLT12, T <sub>j</sub> = 175 °C  Refer to Figure 15 for gate current  waveform		tbd		ns
Turn-On Energy Per Pulse	E <sub>on</sub>			tbd		μJ
Turn-Off Energy Per Pulse	E <sub>off</sub>			tbd		μJ
Total Switching Energy	E <sub>ts</sub>			tbd		μJ
Free-wheeling Silicon Carbide Schottl	ky Diode					
Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 100 A, V <sub>GE</sub> = 0 V, T <sub>i</sub> = 25 °C (175 °C)		1.5		V
Diode Knee Voltage	$V_{D(knee)}$	$T_j = 25  ^{\circ}\text{C}, I_F = 1  \text{mA}$		0.8		V
Peak Reverse Recovery Current	I <sub>rrm</sub>	I <sub>F</sub> = 100 A, V <sub>GE</sub> = 0 V, V <sub>R</sub> = 800 V,		tbd		Α
Reverse Recovery Time	t <sub>rr</sub>	-dI <sub>F</sub> /dt = 625 A/µs, T <sub>j</sub> = 175 °C		tbd		ns
Rise Time	t <sub>r</sub>			tbd		ns
Fall Time	t <sub>f</sub>	$V_{DD} = 800 \text{ V}, I_D = 100 \text{ A},$		tbd		ns
Turn-On Energy Loss Per Pulse	E <sub>on</sub>	$R_{gon} = R_{goff} = tbd \Omega,$ $T_{j} = 25 \text{ °C}$		tbd		μJ
Turn-Off Energy Loss Per Pulse	$E_{off}$			tbd		μJ
Reverse Recovery Charge	$Q_{rr}$			tbd		nC
Rise Time	t <sub>r</sub>	<u> </u>		tbd		ns
Fall Time	$t_{f}$	$V_{DD}$ = 800 V, $I_{D}$ = 100 A,		tbd		ns
Turn-On Energy Loss Per Pulse	E <sub>on</sub>	$R_{gon} = R_{goff} = tbd \Omega,$		tbd		μJ
Turn-Off Energy Loss Per Pulse	E <sub>off</sub>	T <sub>j</sub> = 175 °C		tbd		μJ
Reverse Recovery Charge	Q <sub>rr</sub>			tbd		nC



**Figures** 

TBD

TBD

Figure 1: Typical Output Characteristics at 25 °C

Figure 2: Typical Output Characteristics at 125 °C

**TBD** 

TBD

Figure 3: Typical Output Characteristics at 175 °C

Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

TBD

TBD

Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

Figure 6: Typical Blocking Characteristics



TBD

**TBD** 

Figure 7: Capacitance Characteristics

Figure 8: Capacitance Characteristics

TBD

TBD

Figure 9: Typical Hard-switched Turn On Waveforms

Figure 10: Typical Hard-switched Turn Off Waveforms

TBD

TBD

Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature



**TBD** 

TBD

Figure 13: Typical Turn On Energy Losses vs. Drain Current Figure 14: Typical Turn Off Energy Losses vs. Drain Current

TBD

TBD

Figure 15: Typical Gate Current Waveform

Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency <sup>1</sup>

TBD

TBD

<sup>&</sup>lt;sup>1</sup> – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.



TBD TBD

Figure 19: Turn-Off Safe Operating Area

Figure 20: Transient Thermal Impedance

TBD

Figure 21: Typical FWD Forward Characteristics



## Gate Drive Theory of Operation for the GA100SICP12-227

The SJT transistor is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 22.

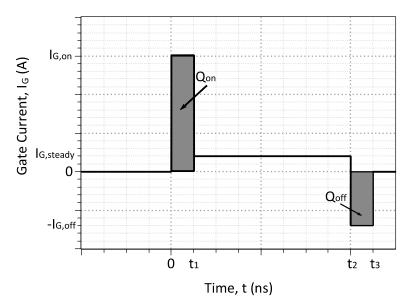


Figure 22: Idealized Gate Current Waveform

# Gate Currents, $\textbf{I}_{G,pk}\textit{I-}\textbf{I}_{G,pk}$ and Voltages during Turn-On and Turn-Off

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge,  $Q_G$ , for turn-on is supplied by a burst of high gate current,  $I_{G,on}$ , until the gate-source capacitance,  $C_{GS}$ , and gate-drain capacitance,  $C_{GD}$ , are fully charged.

$$I_{G,on} * t_1 \ge Q_{gs} + Q_{gd}$$

The  $I_{G,pon}$  pulse should ideally terminate, when the drain voltage falls to its on-state value, in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the  $I_{G,on}$  pulse is affected by the parasitic inductances,  $L_{par}$  in the module and drive circuit. A voltage developed across the parasitic inductance in the source path,  $L_s$ , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The applied gate voltage should be maintained high enough, above the  $V_{GS,ON}$  level to counter these effects.

A high negative peak current,  $-I_{G,off}$  is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with  $V_{GS} = 0$  V, a negative gate voltage  $V_{GS}$  may be used in order to speed up the turn-off transition.

#### Steady On-State

After the device is turned on,  $I_G$  may be advantageously lowered to  $I_{G,steady}$  for reducing unnecessary gate drive losses. The  $I_{G,steady}$  is determined by noting the DC current gain,  $h_{FE}$ , of the device

The desired  $I_{G,steady}$  is determined by the peak device junction temperature  $T_J$  during operation, drain current  $I_D$ , DC current gain  $h_{FE}$ , and a 50 % safety margin to ensure operating the device in the saturation region with low on-state voltage drop by the equation:

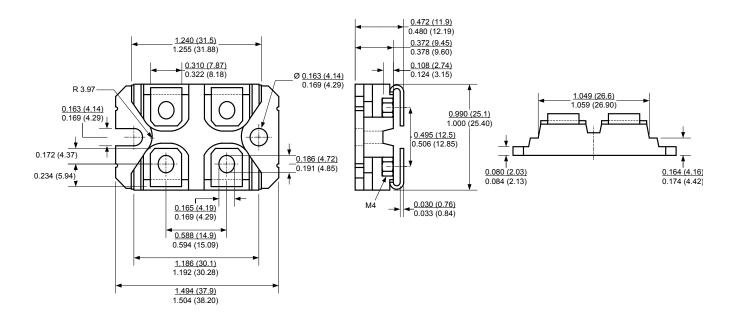
$$I_{G,steady} \approx \frac{I_D}{h_{FE}(T, I_D)} * 1.5$$



#### **Package Dimensions:**

**SOT-227** 

#### **PACKAGE OUTLINE**



- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
  2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History					
Date	Revision	Comments	Supersedes		
2014/08/25	1	Gate Drive Theory Update			
2013/09/12	0	Initial release			

Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

GeneSiC Semiconductor, Inc. reserves right to make changes to the product specifications and data in this document without notice.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.



## **SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (<a href="http://www.genesicsemi.com/images/products-sic/igbt-copack/GA100SICP12-227-spice.pdf">http://www.genesicsemi.com/images/products-sic/igbt-copack/GA100SICP12-227-spice.pdf</a>) into LTSPICE (version 4) software for simulation of the GA100SICP12-227.

```
MODEL OF GeneSiC Semiconductor Inc.
*
     $Revision: 1.0
                                 $
     $Date: 20-SEP-2013
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
    Dulles, VA 20166
     http://www.genesicsemi.com/index.php/sic-products/copack
     COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
* Start of GA100SICP12-227 SPICE Model
.SUBCKT GA100SIPC12 DRAIN GATE SOURCE
Q1 DRAIN GATE SOURCE GA100SIPC12 Q
D1 SOURCE DRAIN GA100SIPC12 D1
D2 SOURCE DRAIN GA100SIPC12 D2
Q2 DRAIN GATE SOURCE GA100SIPC12 Q
D3 SOURCE DRAIN GA100SIPC12 D1
D4 SOURCE DRAIN GA100SIPC12 D2
.model GA100SIPC12 Q NPN
           5.00E-47
+ IS
                            ISE
                                       1.26E-28
                                                        ΕG
                                                                   3.2
+ BF
           100
                                       0.55
                                                                   3500
                            BR
                                                        IKF
                                       2
+ NF
           1
                           NE
                                                        RB
                                                                   0.4
+ RE
           0.01
                           RC
                                       0.011
                                                        CJC
                                                                   1.75E-09
+ VJC
           3
                           MJC
                                       0.5
                                                                   5.57E-09
                                                        CJE
+ VJE
                                                                   3
                           MJE
                                       0.5
                                                        XTI
                                                             GeneSiC Semi
+ XTB
           -1.2
                            TRC1
                                       7.00E-03
                                                        MFG
.MODEL GA100SIPC12 D1 D
          1.99E-16
+ IS
                           RS
                                       0.015652965
                                                                   1
                                                        Ν
                                                                   3
+ IKF
           1000
                            ΕG
                                       1.2
                                                        XTI
           0.0042
+ TRS1
                            TRS2
                                       1.3E-05
                                                        CJO
                                                                   3.86E-09
+ VJ
           1.362328465
                                       0.48198551
                                                        FC
                                                                   0.5
                            M
           1.00E-10
                            IAVE
                                       50
+ TT
.MODEL GA100SIPC12 D2 D
           1.54E-19
                                       0.1
                                                                   3.941
+ IS
                            RS
                                                        Ν
+ EG
           3.23
                            TRS1
                                       -0.004
                                                        IKF
                                                                   19
+ XTI
           0
                            FC
                                       0.5
                                                        TT
                                                                   0
.ENDS
```

\* End of GA100SICP12-227 SPICE Model